

ISSUED BY Shenzhen BALUN Technology Co., Ltd.

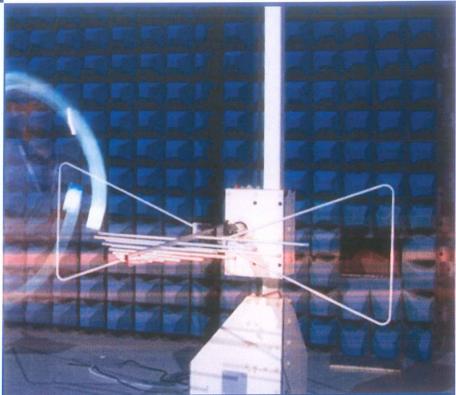


FOR

Intel Dual Band Wireless-AC 3165

ISSUED TO Handheld Group AB

Kinnegatan 17, 53133 Lidköping Sweden



Tested by: Xia Long Xia Long (Engineer) Date Approved by Wei Yanquan (Chief Engineer) Date by 17, 2017

Report No.:

BL-SZ1670309-401

EUT Name:

Model Name: 3165NGW Brand Name: Handheld

Intel Dual Band Wireless-AC 3165

Test Standard: 47 CFR Part 15 Subpart B

FCC ID: YY3-1824V1

Test Conclusion: Pass

Test Date: Nov. 11, 2016 ~ Nov. 18, 2016

Date of Issue:

May 17, 2017

NOTE: This test report can be duplicated completely for the legal use with the approval of the applicant; it shall not be reproduced except in full, without the written approval of Shenzhen BALUN Technology Co., Ltd. BALUN Laboratory. Any objections should be raised within thirty days from the date of issue. To validate the report, please visit BALUN website.



Revision History

VersionIssue DateRevisions ContentRev. 01May 15, 2017Initial Issue

Rev. 02 May 17, 2017 Increase the relevant description of the

Test Configurations on page 10

TABLE OF CONTENTS

1 GENERAL INFORMATION	4
1.1 Identification of the Testing Laboratory	4
1.2 Identification of the Responsible Testing Location	4
1.3 Laboratory Condition	4
1.4 Announce	4
2 PRODUCT INFORMATION	5
2.1 Applicant Information	5
2.2 Manufacturer Information	5
2.3 General Description for Equipment under Test (EUT)	5
2.4 Ancillary Equipment	6
2.5 Technical Information	6
3 SUMMARY OF TEST RESULTS	7
3.1 Test Standards	7
3.2 Verdict	7
3.3 Test Uncertainty	7
4 GENERAL TEST CONFIGURATIONS	8
4.1 Test Environments	8
4.2 Test Equipment List	8
4.3 Test Enclosure list	9
4.4 Test Configurations	10
4.5 Test Setups	11
4.6 Test Conditions	13
5 TEST ITEMS	14
5.1 Emission Tests	14
ANNEX A TEST RESULTS	16
A.1 Radiated Emission	16

Report No.: BL-SZ1670309-401



A.2 Conducted Emission	20
ANNEX B TEST SETUP PHOTOS	22
ANNEX C EUT EXTERNAL PHOTOS	22
ANNEX D EUT INTERNAL PHOTOS	22



1 GENERAL INFORMATION

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.			
	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi			
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R.			
	China			
Phone Number	+86 755 6685 0100			
Fax Number	+86 755 6182 4271			

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.		
	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi		
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R.		
	China		
	The laboratory has been listed by Industry Canada to perform		
	electromagnetic emission measurements. The recognition numbers		
	of test site are 11524A-1.		
A compalitation	The laboratory has been listed by US Federal Communications		
Accreditation	Commission to perform electromagnetic emission measurements.		
Certificate	The recognition numbers of test site are 832625.		
	The laboratory is a testing organization accredited by China National		
	Accreditation Service for Conformity Assessment (CNAS) according		
	to ISO/IEC 17025. The accreditation certificate number is L6791.		
	All measurement facilities used to collect the measurement data are		
December	located at Block B, FL 1, Baisha Science and Technology Park,		
Description	Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province,		
	P. R. China 518055		

1.3 Laboratory Condition

Ambient Temperature	20°C~25°C
Ambient Relative Humidity	45% - 55%
Ambient Pressure	100 kPa - 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v6.3.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without



prior written approval from the laboratory.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Handheld Group AB
Address	Kinnegatan 17, 53133 Lidköping Sweden

2.2 Manufacturer Information

Manufacturer	INTEL MOBILE COMMUNICATIONS		
Addross	100 Center Point Circle, Suite 200 Columbia, South Carolina, 29210		
Address	USA		

2.3 General Description for Equipment under Test (EUT)

EUT Name	Intel Dual Band Wireless-AC 3165	
Model Name Under Test	3165NGW	
Series Model Name	N/A	
Description of Model	N/A	
name differentiation	N/A	
Hardware Version	IBWHH-210	
Software Version	N/A	
Dimensions (Approx.)	N/A	
Weight (Approx.)	N/A	
The Highest Speed of	N/A	
Processor		
Network and Wireless	Bluetooth, WIFI, GPS	
connectivity		



2.4 Ancillary Equipment

	Rugged Tablet PC (Host)	
Ancillant Fattinment	Brand Name	Handheld
Ancillary Equipment	Model No.	ALGIZ 8X
	Serial No.	N/A

2.5 Technical Information

N/A



3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title	
1	FCC 47 CFR Part 15	Unintentional Radiators	
	Subpart B (10-1-15 Edition)		
		American National Standard for Methods of	
	2 ANSI C63.4-2014	Measurement of Radio-Noise Emissions from	
2		Low-Voltage Electrical and Electronic Equipment in the	
		Range of 9 kHz to 40 GHz	

3.2 Verdict

No.	Description	FCC Rule	ISED Rule	Test Verdict	Result
1	Radiated Emission	15.109	Class B	Pass	Annex A .1
2	Conducted Emission, AC Ports	15.107	Class B	Pass	Annex A .2

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.23 dB
Radiated emissions (30 MHz-1 GHz)	4.30 dB
Radiated emissions (1 GHz-18 GHz)	4.81 dB
Radiated emissions (18 GHz-40 GHz)	5.71 dB



4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

Environment		Selected Values During Tests						
Parameter	Temperature	Voltage	Relative Humidity	Ambient Pressure				
Normal Temperature,								
Normal Voltage	23°C~26°C	AC 120 V/60 Hz	50%-55%	100 to 102 kPa				
(NTNV)								

4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWA RZ	ESRP	101036	2016.07.05	2017.07.04	\boxtimes
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9163	9163-977	2016.07.19	2018.07.18	\boxtimes
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	9120D-1600	2016.07.12	2018.07.11	
Anechoic Chamber	EMC Electronic Co., Ltd	20.10*11.60 *7.35m	N/A	2016.08.09	2018.08.08	\boxtimes

Radiated Emission Test For Frequency Above 1 GHz											
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use					
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2016.09.09	2017.09.08	\boxtimes					
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2015.07.22	2017.07.21						
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	9120D-1148	2015.07.22	2017.07.21	\boxtimes					
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.24	2019.02.23	\boxtimes					

Conducted disturbance Test										
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use				
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2016.07.05	2017.07.04	\boxtimes				
LISN	SCHWARZBECK	NSLK 8127	8127-687	2016.07.05	2017.07.04	\boxtimes				
Shielded	ChangNing	CN-130701	130703	N/A	N/A	\boxtimes				
Enclosure	Changing	CIN-130701	130703	IN/A	IN/A					



4.3 Test Enclosure list

Description	Manufacturer	Model	Serial No.	Length	Description	Use
PC	N/A	N/A	N/A	N/A	Special Handled	
Laptop	Apple	A1465	N/A	N/A	N/A	
Printer	HP	DESKJET 1000	N/A	N/A	N/A	
Keyboard	Logitech	Y-BP62a	N/A	N/A	N/A	\boxtimes
Mouse	Logitech	M100	N/A	N/A	N/A	\boxtimes
USB disk	Kingston	N/A	N/A	N/A	N/A	\boxtimes
TF Card	Kingston	N/A	N/A	N/A	N/A	\boxtimes
VGA Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
HDMI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	\boxtimes
DVI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
Coaxial video cable	N/A	N/A	N/A	2.0 m	Shielded with core	
Audio Cable	N/A	N/A	N/A	0.5 m	Shielded with core	
iPhone	Apple	A1586	N/A	N/A	N/A	
Bluetooth Earphone	SAMSUNG	Gear Circle	N/A	N/A	N/A	\boxtimes
GPS/GLONASS Vector signal generator	R&S	N5172B EXG	N/A	N/A	N/A	\boxtimes
WIFI Router	TP-LINK	TL-WDR7500	N/A	N/A	N/A	\boxtimes
Earphone	N/A	OPPO	N/A	1.1 m	N/A	
Car Battery	Camel	55530	N/A	N/A	12 V/55 Ah	
Artificial load	N/A	N/A	N/A	N/A	2.5 Ω/100 W	
Artificial load	N/A	N/A	N/A	N/A	5 Ω/100 W	
Electronic Load	ITECH	IT8511	N/A	N/A	N/A	
USB Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
DC Power Supply	ITECH	IT6863A	60001401068 7210006	N/A	N/A	
LCD Monitor	SAMSUNG	UA32C4000P	N/A	N/A	N/A	
RJ45 Cable	N/A	N/A	N/A	1.5 m	Shielded with core	
Wireless Speaker	One World Technologies	P761	N/A	N/A	N/A	\boxtimes
Television	SAMSUNG	UA32C4000P	N/A	N/A	N/A	\boxtimes



4.4 Test Configurations

Test Configurations (TC) No.	Description
TC01	The Camera Test mode
1001	EUT + Host + Mouse + Keyboard + Television + HDMI Cable + TF Card
	The Video Play test mode
TC02	EUT + Host + Mouse + Keyboard + Television + HDMI Cable + TF Card + WIFI Link + BT
	Link
TC02	The USB test mode
TC03	EUT + Host + Mouse + Television + HDMI Cable + USB Disk + TF Card + GPS RX

Note: TC01 camera test mode will record the contents stored in the TF card.

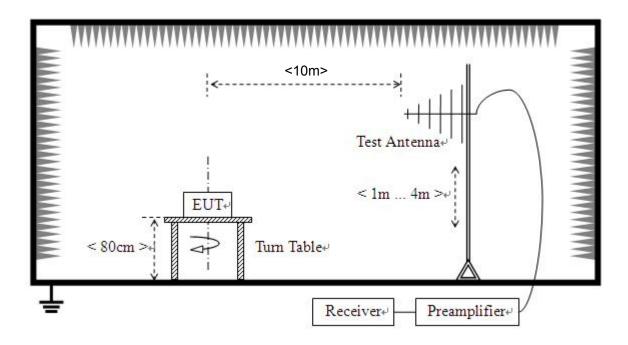
TC02 video play test mode is to read the TF card in the video file.

TC03 USB test mode USB disk and TF card and EUT for data transmission.



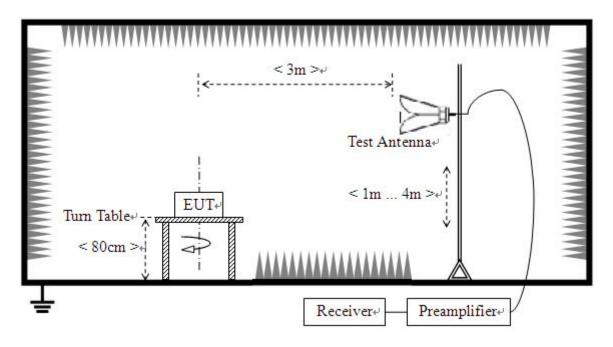
4.5 Test Setups

Test Setup 1



(For Radiated Emission Test (30 MHz-1 GHz))

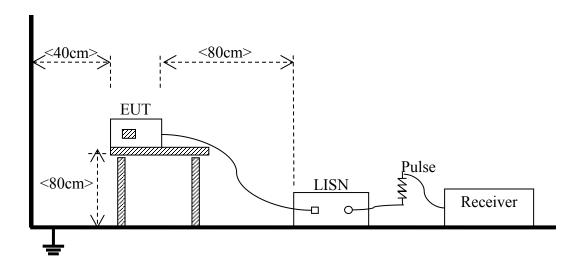
Test Setup 2



(For Radiated Emission Test (above 1 GHz))



Test Setup 3



(For Conducted Emission, AC Ports Test)



4.6 Test Conditions

Test Case	Test Conditions				
	Test Env.	NTNV			
Radiated Emission	Test Setup	Test Setup 1&2			
	Test Configuration	TC01~TC03 Note			
Conducted Emission AC	Test Env.	NTNV			
Conducted Emission, AC Ports	Test Setup	Test Setup 3			
FUILS	Test Configuration	TC01~TC03 Note			

Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The Camera Test Mode is the worst mode in this report.



5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range	Class B	(at 3 m)	Class A (at 10 m)		
	Field Strength Field Strength		Field Strength	Field Strength	
(MHz)	(μV/m)	(dBµV/m)	(μV/m)	(dBµV/m)	
30 - 88	100	40	90	39	
88 - 216	150	43.5	150	43.5	
216 - 960	200	46	210	46.4	
Above 960	500	54	300	49.5	

NOTE:

- 1) Field Strength ($dB\mu V/m$) = 20*log [Field Strength ($\mu V/m$)].
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) The limits using ANSI C63.4.

5.1.1.2 Test Setup

Refer to 4.5 section (test setups1 to test setups2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

5.1.1.4 Test Result

Please refer to ANNEX A.1.



5.1.2 Conducted Emission

5.1.2.1 Test Limit

	Class A				
Frequency range (MHz)	Quasi-peak	Average			
	(dBµV)	(dBµV)			
0.15 - 0.50	79	66			
0.50 - 30	73	60			

	Class B				
Frequency range (MHz)	Quasi-peak	Average			
	(dBµV)	(dBµV)			
0.15 - 0.50	66 to 56	56 to 46			
0.50 - 5	56	46			
5 - 30	60	50			

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50 MHz.
- 3) The limit using ANSI C63.4.

5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

The EUT is connected to the power mains through a LISN which provides 50 $\Omega/50~\mu H$ of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.1.2.4 Test Result

Please refer to ANNEX A.2.



ANNEX A TEST RESULTS

A.1 Radiated Emission

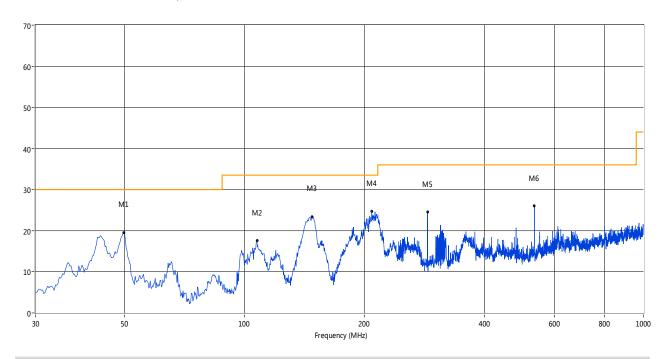
Note 1: The symbol of "--" in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Test Data and Plots

The Camera Test Mode

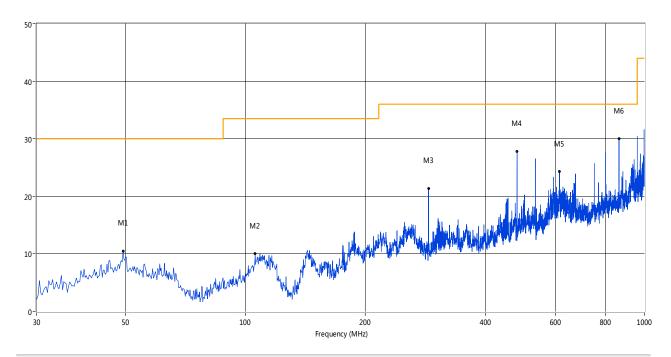
A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(o)	(cm)		
1	49.880	19.50	-13.98	30.0	10.50	Peak	154.00	100	Vertical	Pass
2	107.581	17.55	-16.03	33.5	15.95	Peak	154.00	100	Vertical	Pass
3	148.068	23.40	-19.57	33.5	10.10	Peak	0.00	100	Vertical	Pass
4	208.678	24.68	-16.07	33.5	8.82	Peak	355.00	100	Vertical	Pass
5	287.956	24.51	-13.72	36.0	11.49	Peak	335.00	100	Vertical	Pass
6	533.304	26.08	-8.25	36.0	9.92	Peak	360.00	100	Vertical	Pass



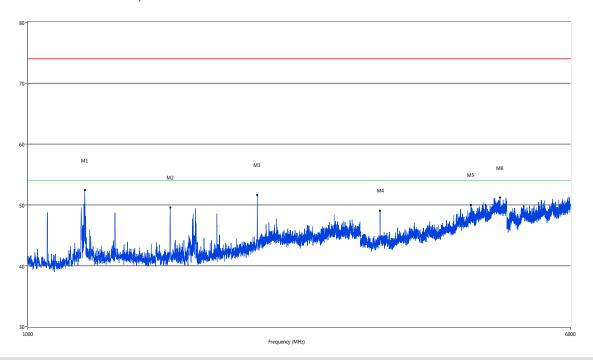
A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdi
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		ct
1	49.395	10.50	-13.92	30.0	19.50	Peak	66.00	100	Horizontal	Pass
2	105.884	10.09	-15.69	33.5	23.41	Peak	73.00	100	Horizontal	Pass
3	287.956	21.40	-13.72	36.0	14.60	Peak	319.00	100	Horizontal	Pass
4	479.968	27.83	-9.69	36.0	8.17	Peak	0.00	100	Horizontal	Pass
5	612.824	24.30	-6.87	36.0	11.70	Peak	206.00	100	Horizontal	Pass
6	863.992	29.98	-3.29	36.0	6.02	Peak	223.00	100	Horizontal	Pass



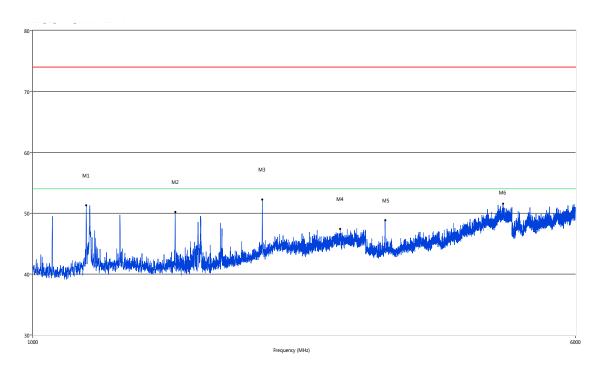
A.1.3 Test Antenna Vertical, 1 GHz – 6 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(0)	(cm)		
1	1206.95	52.45	-5.17	74.0	21.55	Peak	298.80	100	Vertical	Pass
2	1599.85	49.60	-4.33	74.0	24.40	Peak	18.60	100	Vertical	Pass
3	2133.22	51.65	-1.07	74.0	22.35	Peak	294.60	100	Vertical	Pass
4	3199.45	49.05	9.22	74.0	24.95	Peak	0.80	100	Vertical	Pass
5	4319.67	49.99	12.10	74.0	24.01	Peak	187.00	100	Vertical	Pass
6	4756.06	51.19	13.58	74.0	22.81	Peak	221.70	100	Vertical	Pass



A.1.4 Test Antenna Horizontal, 1 GHz – 6 GHz



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Table	Height	ANT	Verdict
	(MHz)	(dBuV/m)		(dBuV/m)	(dB)		(o)	(cm)		
1	1192.95	51.28	-5.39	74.0	22.72	Peak	303.50	100	Horizontal	Pass
2	1599.85	50.21	-4.33	74.0	23.79	Peak	328.60	100	Horizontal	Pass
3	2133.72	52.26	-1.04	74.0	21.74	Peak	282.50	100	Horizontal	Pass
4	2759.56	47.45	1.90	74.0	26.55	Peak	-0.00	100	Horizontal	Pass
5	3200.20	48.88	9.22	74.0	25.12	Peak	359.40	100	Horizontal	Pass
6	4723.82	51.54	13.63	74.0	22.46	Peak	271.40	100	Horizontal	Pass

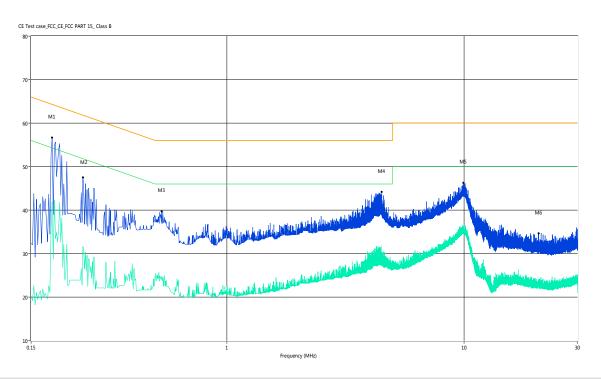


A.2 Conducted Emission

Test Data and Plots

The Camera Test Mode

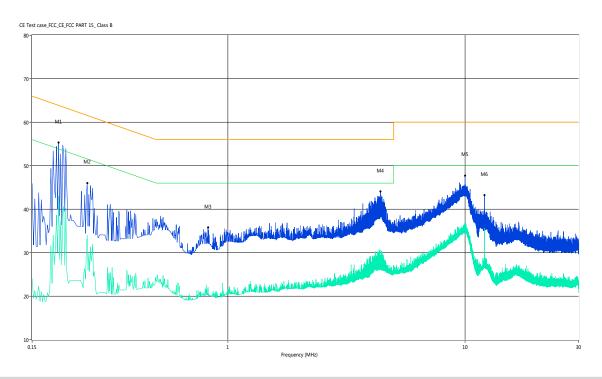
A.2.1 L Phase



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.18	56.6	11.00	65.0	8.40	Peak	L Line	Pass
1**	0.18	42.0	11.00	55.0	13.00	AV	L Line	Pass
2	0.25	47.5	11.00	63.2	15.70	Peak	L Line	Pass
2**	0.25	31.6	11.00	53.2	21.60	AV	L Line	Pass
3	0.53	39.7	11.00	56.0	16.30	Peak	L Line	Pass
3**	0.53	24.6	11.00	46.0	21.40	AV	L Line	Pass
4	4.50	44.2	11.00	56.0	11.80	Peak	L Line	Pass
4**	4.50	30.3	11.00	46.0	15.70	AV	L Line	Pass
5	9.90	46.3	11.00	60.0	13.70	Peak	L Line	Pass
5**	9.90	34.9	11.00	50.0	15.10	AV	L Line	Pass
6	20.56	34.7	11.00	60.0	25.30	Peak	L Line	Pass
6**	20.56	23.4	11.00	50.0	26.60	AV	L Line	Pass



A.2.2 N Phase



No.	Frequency	Results	Factor (dB)	Limit	Margin	Detector	Line	Verdict
	(MHz)	(dBuV)		(dBuV)	(dB)			
1	0.19	55.3	11.00	64.7	9.40	Peak	N Line	Pass
1**	0.19	43.0	11.00	54.7	11.70	AV	N Line	Pass
2	0.26	46.0	11.00	63.0	17.00	Peak	N Line	Pass
2**	0.26	34.0	11.00	53.0	19.00	AV	N Line	Pass
3	0.83	35.8	11.00	56.0	20.20	Peak	N Line	Pass
3**	0.83	22.0	11.00	46.0	24.00	AV	N Line	Pass
4	4.40	44.1	11.00	56.0	11.90	Peak	N Line	Pass
4**	4.40	29.4	11.00	46.0	16.60	AV	N Line	Pass
5	10.00	47.7	11.00	60.0	12.30	Peak	N Line	Pass
5**	10.00	35.9	11.00	50.0	14.10	AV	N Line	Pass
6	12.05	43.2	11.00	60.0	16.80	Peak	N Line	Pass
6**	12.05	35.7	11.00	50.0	14.30	AV	N Line	Pass



ANNEX B TEST SETUP PHOTOS

Please refer the document "BL-SZ1670309-AE.PDF".

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document "BL-SZ1670309-AW.PDF".

ANNEX D EUT INTERNAL PHOTOS

Please refer the document "BL-SZ1670309-AI.PDF".

--END OF REPORT--